

July 2008

### FDB031N08

# N-Channel PowerTrench<sup>®</sup> MOSFET 75V, 235A, 3.1m $\Omega$

#### **Features**

- $R_{DS(on)} = 2.4 m\Omega$  (Typ.)@  $V_{GS} = 10 V$ ,  $I_{D} = 75 A$
- · Fast switching speed
- · Low gate charge
- High performance trench technology for extremely low R<sub>DS(on)</sub>
- · High power and current handling capability
- · RoHS compliant

### **Description**

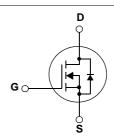
This N-Channel MOSFET is produced using Fairchild Semiconductor's adcanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

### **Application**

• DC to DC convertors / Synchronous Rectification







### MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted\*

Symbol	Parameter			FDB031N08	Units
V <sub>DSS</sub>	Drain to Source Voltage			75	V
V <sub>GSS</sub>	Gate to Source Voltage			±20	V
	Drain Current -	Continuous (T <sub>C</sub> = 25°C, Silicon	Limited)	235*	Α
I <sub>D</sub>		Continuous (T <sub>C</sub> = 100°C, Silicon		165*	А
	-	Continuous (T <sub>C</sub> = 25°C, Packa	ge Limited)	120	А
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)		940	А
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	1995	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		(Note 3)	5.5	V/ns
n	Dower Discinstian	$(T_C = 25^{\circ}C)$		375	W
P <sub>D</sub> Power Dissipation		- Derate above 25°C		2.5	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 to +175	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C

\*Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 120A.

#### Thermal Characteristics

Symbol	Parameter Ratin		Units
$R_{ heta JC}$	Thermal Resistance, Junction to Case 0.4		
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	sistance, Junction to Ambient 62.5	

### Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB031N08	FDB031N08	D2-PAK	330mm	24mm	800

### **Electrical Characteristics**

Parameter	Test Conditions	Min.	Тур.	Max.	Units
cteristics					
Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_C = 25^{\circ} C$	75	-	-	V
Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C	-	0.05	-	V/°C
Zoro Gata Voltago Prain Current	$V_{DS} = 75V, V_{GS} = 0V$	-	-	1	
Zero Gate Voltage Drain Current	$V_{DS} = 75V, T_C = 150^{\circ}C$	-	-	500	μΑ
Gate to Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$	-	-	±100	nA
	Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current				

#### **On Characteristics**

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250\mu A$	2.5	3.5	4.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 75A$	ı	2.4	3.1	mΩ
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_D = 75A$ (Note 4)	1	180	-	S

### **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V f = 1MHz		11400	15160	pF
C <sub>oss</sub>	Output Capacitance			1360	1810	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			595	800	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		-	169	220	nC
$Q_{gs}$	Gate to Source Gate Charge V <sub>DS</sub> = 60V, I <sub>D</sub> = 75A		-	60	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10V (Note 4, 5)	-	47	-	nC

#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	230	470	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD} = 37.5V, I_{D} = 75A$	-	191	392	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{GEN} = 25\Omega, V_{GS} = 10V$	-	335	680	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)	-	121	252	ns

### Da Drain-Source Diode Characteristics

Is	Maximum Continuous Drain to Source Diode Forward Current			-	235	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current			-	940	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 75A$	-	-	1.3	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0V, I <sub>SD</sub> = 75A	-	53	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$ (Note	1) -	77	-	nC

#### Notes

- Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 0.71mH,  $I_{AS}$  = 75A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25°C
- 3.  $I_{SD} \le 75 A$ ,  $di/dt \le 200 A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width  $\leq 300 \mu s, \ Duty \ Cycle \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

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### **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

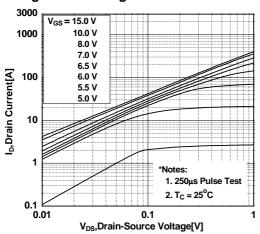


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

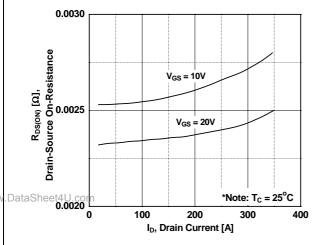
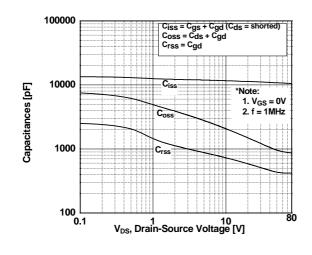


Figure 5. Capacitance Characteristics



**Figure 2. Transfer Characteristics** 

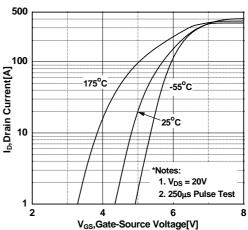


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

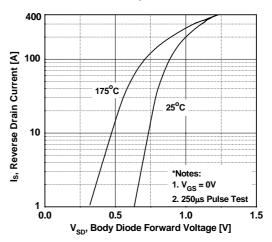
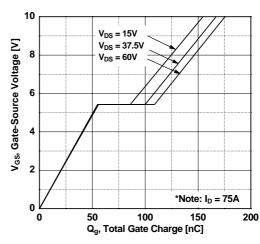


Figure 6. Gate Charge Characteristics



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### **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

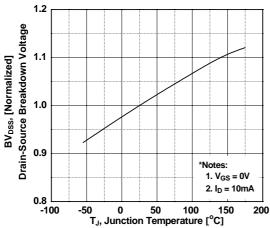


Figure 9. Maximum Safe Operating Area

Figure 8. On-Resistance Variation vs. Temperature

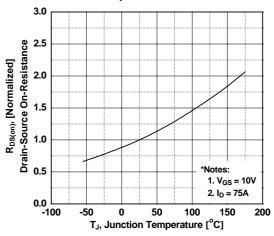
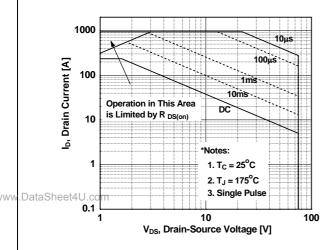


Figure 10. Maximum Drain Current vs. Case Temperature



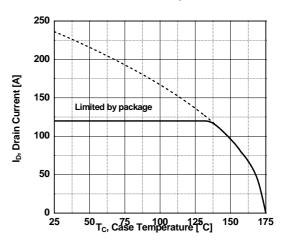
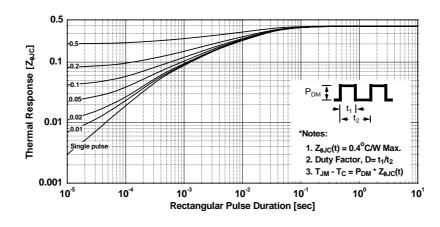
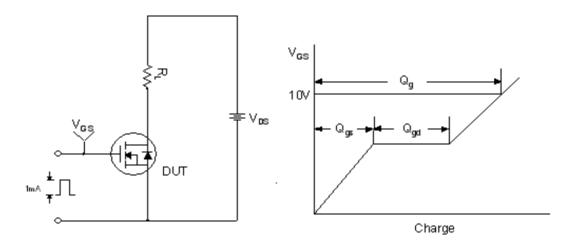


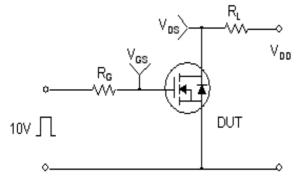
Figure 11. Transient Thermal Response Curve

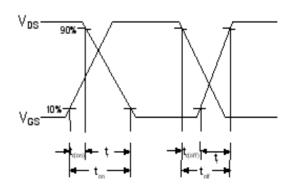


### **Gate Charge Test Circuit & Waveform**



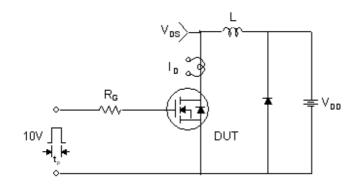
#### **Resistive Switching Test Circuit & Waveforms**

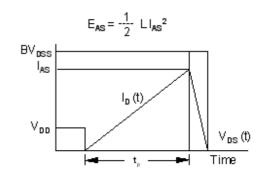




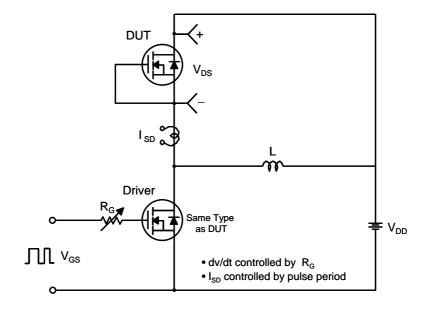
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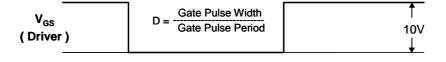
**Unclamped Inductive Switching Test Circuit & Waveforms** 



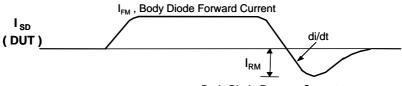


#### Peak Diode Recovery dv/dt Test Circuit & Waveforms

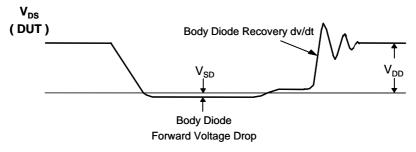




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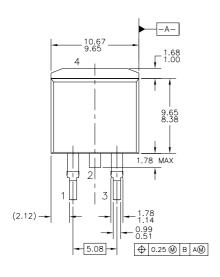
Body Diode Reverse Current

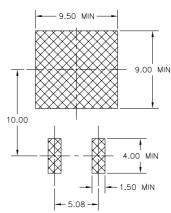


#### **Mechanical Dimensions**

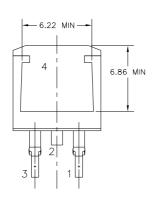
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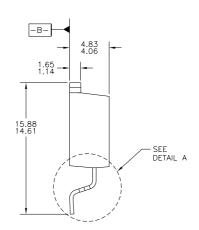
## D2-PAK

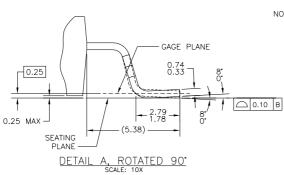




LAND PATTERN RECOMMENDATION







TO263A02REVD

- NOTES: UNLESS OTHERWISE SPECIFIED

  A) ALL DIMENSIONS ARE IN MILLIMETERS.

  B) REFERENCE JEDEC, TO-263, ISSUE D, VARIATION AB, DATED JULY 2003.

  C) DIMENSIONING AND TOLERANCING PER ANSI Y14.5M 1982.

  D) LOCATION OF THE PIN HOLE MAY VARY (LOWER LEFT CORNER, LOWER CENTER AND CENTER OF THE PACKAGE).

  B) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL.

Dimensions in Millimeters



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